Erratum: Reference Correlation of the Thermal Conductivity of Sulfur Hexafluoride from the Triple Point to 1000 K and up to 150 MPa [J. Phys. Chem. Ref. Data 41, 023104 (2012)]

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Erratum: Reference Correlation of the Thermal Conductivity of Sulfur Hexafluoride from the Triple Point to 1000 K and up to 150 MPa [J. Phys. Chem. Ref. Data 41, 023104 (2012)]

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Two corrections are required to the original article,¹ as detailed below.

- 1. In the text below Eq. (11), the reference temperature $T_{\rm ref}$ should be 478.08 K instead of 717.12 K.
- 2. Table 5 should be replaced by the table below.

TABLE 5. Sample points for computer verification of the correlating equations.

T (K)	$ ho (\mathrm{kg} \mathrm{m}^{-3})$	$\lambda~(mWm^{-1}K^{-1})$
298.15	0.00	12.95
298.15	100.00	14.13
298.15	1600.00	69.73
310.00	0.00	13.83
310.00	1200.00	48.70 ^a
310.00	1200.00	48.95 ^b
480.00	100.00	28.85

^aComputed with modified Olchowy-Sengers critical enhancement; the viscosity at this point for use in Eq. (8) was taken (Ref. 8) as $\eta = 89.590 \,\mu\text{Pa}\,\text{s}$ and all other properties required for the enhancement term are from Guder and Wagner (Ref. 6).

^bComputed with empirical critical enhancement, Eq. (12).

A software implementation of this correlation in a format compatible with REFPROP (Ref. 2) is available from the authors.

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 ¹M. J. Assael, I. A. Kioni, K. D. Antoniadis, M. L. Huber, I. M. Abdulagatov, and R. A. Perkins, J. Phys. Chem. Ref. Data 41, 023104 (2012).
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